

Notice of References Cited		Application/Control No. 09/840,441	Applicant(s)/Patent Under Reexamination WELLISZ, TADEUSZ Z	
		Examiner Kathryn Odland	Art Unit 3743	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,487,741	01-1996	Maruyama et al.	606/60
	B	US-5,800,436	09-1998	Lerch, Karl-Dieter	606/72
	C	US-3,858,370	01-1975	Halstead, Richard J.	312/352
	D	US-6,679,885	01-2004	Wellisz, Tadeusz Z	606/72
	E	US-6,709,437	03-2004	Wellisz, Tadeusz Z.	606/71
	F	US-6,652,531	11-2003	Wellisz et al.	606/72
	G	US-6,582,435	06-2003	Wellisz et al.	606/72
	H	US-2002/0156477	10-2002	Knopfle et al.	606/75
	I	US-5,941,878	08-1999	Medoff, Robert J.	606/60
	J	US-5,916,217	06-1999	Manthrop et al.	606/72
	K	US-5,707,373	01-1998	Sevrain et al.	606/72
	L	US-4,333,625	06-1982	Haug, Richard	248/216.1
	M	US-4,255,910	03-1981	Wendt, Alan C.	52/481.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.